

<b>Notice of References Cited</b>	Application/Control No. 10/525,060		Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner James A. Dudek		Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,729,319	03-1998	Inou et al.	349/156
*	C	US-6,559,902	05-2003	Kusuda et al.	349/12
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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